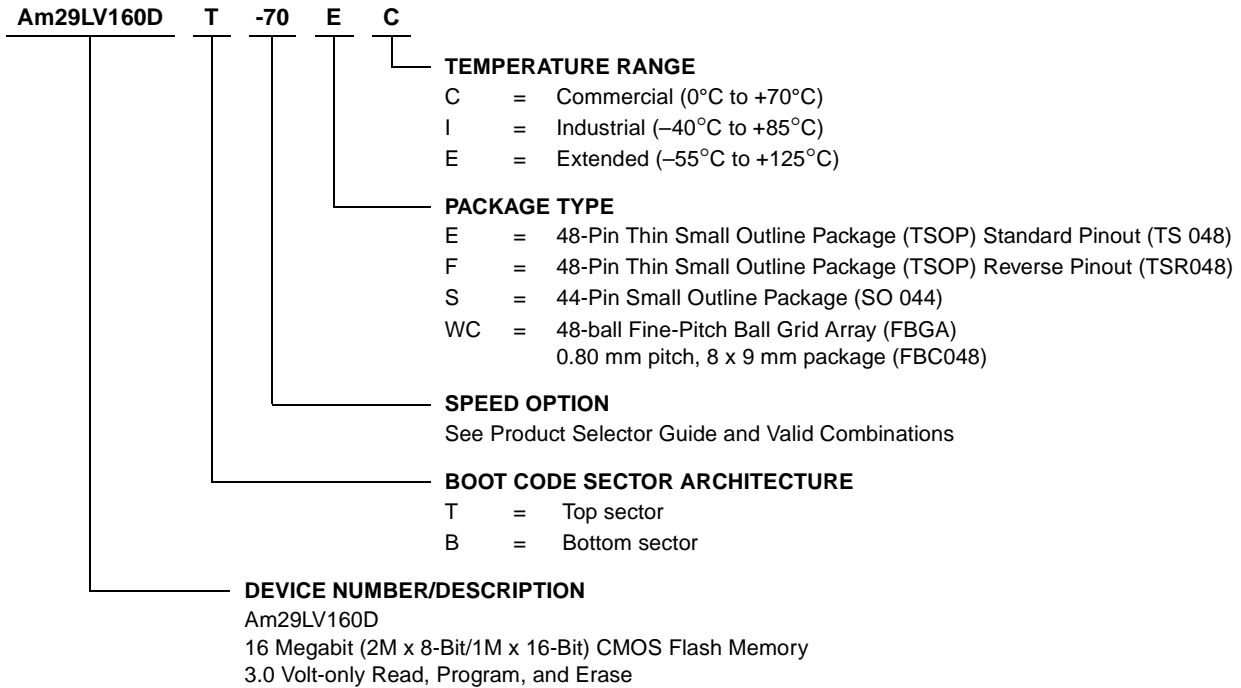


**ORDERING INFORMATION**

**Standard Products**

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



Valid Combinations For TSOP and SO Packages	
Am29LV160DT-70, Am29LV160DB-70	EC, EI, EE, FC, FI, FE, SC, SI, SE
Am29LV160DT-90, Am29LV160DB-90	
Am29LV160DT-120, Am29LV160DB-120	

Valid Combinations for FBGA Packages			
Order Number		Package Marking	
Am29LV160DT-70, Am29LV160DB-70	WCC, WCI, WCE	L160DT70V, L160DB70V	C, I, E
Am29LV160DT-90, Am29LV160DB-90		L160DT90V, L160DB90V	
Am29LV160DT-120, Am29LV160DB-120		L160DT12V, L160DB12V	

**Valid Combinations**

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

## DEVICE BUS OPERATIONS

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is composed of latches that store the commands, along with the address and data information needed to execute the command. The contents of

the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. Table 1 lists the device bus operations, the inputs and control levels they require, and the resulting output. The following subsections describe each of these operations in further detail.

**Table 1. Am29LV160D Device Bus Operations**

Operation	CE#	OE#	WE#	RESET#	Addresses (Note 1)	DQ0– DQ7	DQ8–DQ15	
							BYTE# = V <sub>IH</sub>	BYTE# = V <sub>IL</sub>
Read	L	L	H	H	A <sub>IN</sub>	D <sub>OUT</sub>	D <sub>OUT</sub>	DQ8–DQ14 = High-Z, DQ15 = A-1
Write	L	H	L	H	A <sub>IN</sub>	D <sub>IN</sub>	D <sub>IN</sub>	
Standby	V <sub>CC</sub> ± 0.3 V	X	X	V <sub>CC</sub> ± 0.3 V	X	High-Z	High-Z	High-Z
Output Disable	L	H	H	H	X	High-Z	High-Z	High-Z
Reset	X	X	X	L	X	High-Z	High-Z	High-Z
Sector Protect (Note 2)	L	H	L	V <sub>ID</sub>	Sector Address, A6 = L, A1 = H, A0 = L	D <sub>IN</sub>	X	X
Sector Unprotect (Note 2)	L	H	L	V <sub>ID</sub>	Sector Address, A6 = H, A1 = H, A0 = L	D <sub>IN</sub>	X	X
Temporary Sector Unprotect	X	X	X	V <sub>ID</sub>	A <sub>IN</sub>	D <sub>IN</sub>	D <sub>IN</sub>	High-Z

**Legend:**

L = Logic Low = V<sub>IL</sub>, H = Logic High = V<sub>IH</sub>, V<sub>ID</sub> = 12.0 ± 0.5 V, X = Don't Care, A<sub>IN</sub> = Address In, D<sub>IN</sub> = Data In, D<sub>OUT</sub> = Data Out

**Notes:**

- Addresses are A19:A0 in word mode (BYTE# = V<sub>IH</sub>), A19:A-1 in byte mode (BYTE# = V<sub>IL</sub>).
- The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector Protection/Unprotection" section.

## Word/Byte Configuration

The BYTE# pin controls whether the device data I/O pins DQ15–DQ0 operate in the byte or word configuration. If the BYTE# pin is set at logic '1', the device is in word configuration, DQ15–DQ0 are active and controlled by CE# and OE#.

If the BYTE# pin is set at logic '0', the device is in byte configuration, and only data I/O pins DQ0–DQ7 are active and controlled by CE# and OE#. The data I/O pins DQ8–DQ14 are tri-stated, and the DQ15 pin is used as an input for the LSB (A-1) address function.

## Requirements for Reading Array Data

To read array data from the outputs, the system must drive the CE# and OE# pins to V<sub>IL</sub>. CE# is the power control and selects the device. OE# is the output control and gates array data to the output pins. WE# should re-

main at V<sub>IH</sub>. The BYTE# pin determines whether the device outputs array data in words or bytes.

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device remains enabled for read access until the command register contents are altered.

See "Reading Array Data" for more information. Refer to the AC Read Operations table for timing specifications and to Figure 13 for the timing diagram. I<sub>CC1</sub> in the DC Characteristics table represents the active current specification for reading array data.

## Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive WE# and CE# to  $V_{IL}$ , and OE# to  $V_{IH}$ .

For program operations, the BYTE# pin determines whether the device accepts program data in bytes or words. Refer to “Word/Byte Configuration” for more information.

The device features an **Unlock Bypass** mode to facilitate faster programming. Once the device enters the Unlock Bypass mode, only two write cycles are required to program a word or byte, instead of four. The “Word/Byte Program Command Sequence” section has details on programming data to the device using both standard and Unlock Bypass command sequences.

An erase operation can erase one sector, multiple sectors, or the entire device. Tables 2 and 3 indicate the address space that each sector occupies. A “sector address” consists of the address bits required to uniquely select a sector. The “Command Definitions” section has details on erasing a sector or the entire chip, or suspending/resuming the erase operation.

After the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on DQ7–DQ0. Standard read cycle timings apply in this mode. Refer to the “Autoselect Mode” and “Autoselect Command Sequence” sections for more information.

$I_{CC2}$  in the DC Characteristics table represents the active current specification for the write mode. The “AC Characteristics” section contains timing specification tables and timing diagrams for write operations.

## Program and Erase Operation Status

During an erase or program operation, the system may check the status of the operation by reading the status bits on DQ7–DQ0. Standard read cycle timings and  $I_{CC}$  read specifications apply. Refer to “Write Operation Status” for more information, and to “AC Characteristics” for timing diagrams.

## Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the OE# input.

The device enters the CMOS standby mode when the CE# and RESET# pins are both held at  $V_{CC} \pm 0.3$  V. (Note that this is a more restricted voltage range than  $V_{IH}$ .) If CE# and RESET# are held at  $V_{IH}$ , but not within  $V_{CC} \pm 0.3$  V, the device will be in the standby mode, but the standby current will be greater. The device requires standard access time ( $t_{CE}$ ) for read access when the device is in either of these standby modes, before it is ready to read data.

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

In the DC Characteristics table,  $I_{CC3}$  and  $I_{CC4}$  represents the standby current specification.

## Automatic Sleep Mode

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for  $t_{ACC} + 30$  ns. The automatic sleep mode is independent of the CE#, WE#, and OE# control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system.  $I_{CC4}$  in the DC Characteristics table represents the automatic sleep mode current specification.

## RESET#: Hardware Reset Pin

The RESET# pin provides a hardware method of resetting the device to reading array data. When the system drives the RESET# pin to  $V_{IL}$  for at least a period of  $t_{RP}$ , the device **immediately terminates** any operation in progress, tristates all data output pins, and ignores all read/write attempts for the duration of the RESET# pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the RESET# pulse. When RESET# is held at  $V_{SS} \pm 0.3$  V, the device draws CMOS standby current ( $I_{CC4}$ ). If RESET# is held at  $V_{IL}$  but not within  $V_{SS} \pm 0.3$  V, the standby current will be greater.

The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash

memory, enabling the system to read the boot-up firmware from the Flash memory.

If RESET# is asserted during a program or erase operation, the RY/BY# pin remains a "0" (busy) until the internal reset operation is complete, which requires a time of  $t_{READY}$  (during Embedded Algorithms). The system can thus monitor RY/BY# to determine whether the reset operation is complete. If RESET# is asserted when a program or erase operation is not executing (RY/BY# pin is "1"), the reset operation is completed within a time of  $t_{READY}$  (not during Embedded Algorithms). The system can read data  $t_{RH}$  after the RESET# pin returns to  $V_{IH}$ .

Refer to the AC Characteristics tables for RESET# parameters and to Figure 14 for the timing diagram.

## Output Disable Mode

When the OE# input is at  $V_{IH}$ , output from the device is disabled. The output pins are placed in the high impedance state.

Table 2. Sector Address Tables (Am29LV160DT)

Sector	A19	A18	A17	A16	A15	A14	A13	A12	Sector Size (Kbytes/ Kwords)	Address Range (in hexadecimal)	
										Byte Mode (x8)	Word Mode (x16)
SA0	0	0	0	0	0	X	X	X	64/32	000000–00FFFF	00000–07FFF
SA1	0	0	0	0	1	X	X	X	64/32	010000–01FFFF	08000–0FFFF
SA2	0	0	0	1	0	X	X	X	64/32	020000–02FFFF	10000–17FFF
SA3	0	0	0	1	1	X	X	X	64/32	030000–03FFFF	18000–1FFFF
SA4	0	0	1	0	0	X	X	X	64/32	040000–04FFFF	20000–27FFF
SA5	0	0	1	0	1	X	X	X	64/32	050000–05FFFF	28000–2FFFF
SA6	0	0	1	1	0	X	X	X	64/32	060000–06FFFF	30000–37FFF
SA7	0	0	1	1	1	X	X	X	64/32	070000–07FFFF	38000–3FFFF
SA8	0	1	0	0	0	X	X	X	64/32	080000–08FFFF	40000–47FFF
SA9	0	1	0	0	1	X	X	X	64/32	090000–09FFFF	48000–4FFFF
SA10	0	1	0	1	0	X	X	X	64/32	0A0000–0AFFFF	50000–57FFF
SA11	0	1	0	1	1	X	X	X	64/32	0B0000–0BFFFF	58000–5FFFF
SA12	0	1	1	0	0	X	X	X	64/32	0C0000–0CFFFF	60000–67FFF
SA13	0	1	1	0	1	X	X	X	64/32	0D0000–0DFFFF	68000–6FFFF
SA14	0	1	1	1	0	X	X	X	64/32	0E0000–0EFFFF	70000–77FFF
SA15	0	1	1	1	1	X	X	X	64/32	0F0000–0FFFFF	78000–7FFFF
SA16	1	0	0	0	0	X	X	X	64/32	100000–10FFFF	80000–87FFF
SA17	1	0	0	0	1	X	X	X	64/32	110000–11FFFF	88000–8FFFF
SA18	1	0	0	1	0	X	X	X	64/32	120000–12FFFF	90000–97FFF
SA19	1	0	0	1	1	X	X	X	64/32	130000–13FFFF	98000–9FFFF
SA20	1	0	1	0	0	X	X	X	64/32	140000–14FFFF	A0000–A7FFF
SA21	1	0	1	0	1	X	X	X	64/32	150000–15FFFF	A8000–AFFFF
SA22	1	0	1	1	0	X	X	X	64/32	160000–16FFFF	B0000–B7FFF
SA23	1	0	1	1	1	X	X	X	64/32	170000–17FFFF	B8000–BFFFF
SA24	1	1	0	0	0	X	X	X	64/32	180000–18FFFF	C0000–C7FFF
SA25	1	1	0	0	1	X	X	X	64/32	190000–19FFFF	C8000–CFFFF
SA26	1	1	0	1	0	X	X	X	64/32	1A0000–1AFFFF	D0000–D7FFF
SA27	1	1	0	1	1	X	X	X	64/32	1B0000–1BFFFF	D8000–DFFFF
SA28	1	1	1	0	0	X	X	X	64/32	1C0000–1CFFFF	E0000–E7FFF
SA29	1	1	1	0	1	X	X	X	64/32	1D0000–1DFFFF	E8000–EFFFF
SA30	1	1	1	1	0	X	X	X	64/32	1E0000–1EFFFF	F0000–F7FFF
SA31	1	1	1	1	1	0	X	X	32/16	1F0000–1F7FFF	F8000–FBFFF
SA32	1	1	1	1	1	1	0	0	8/4	1F8000–1F9FFF	FC000–FCFFF
SA33	1	1	1	1	1	1	0	1	8/4	1FA000–1FBFFF	FD000–FDFFF
SA34	1	1	1	1	1	1	1	X	16/8	1FC000–1FFFFF	FE000–FFFFF

Note: Address range is A19:A-1 in byte mode and A19:A0 in word mode. See “Word/Byte Configuration” section.